## 2. Specifications

| Characteristics | Item |  | Specifications |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Contact | Arrangement |  | 1 Form A | 1 Form A 1 Form B | 2 Form A |
|  | Contact resistance (Initial) |  | Max. $30 \mathrm{~m} \Omega$ (By voltage drop 6 V DC 1A) |  |  |
|  | Contact material |  | Au-flashed $\mathrm{AgSnO}_{2}$ type |  |  |
| Rating | Nominal switching capacity (resistive load) |  | 8 A 250 V AC, 5A 30V DC | 5 A 250 V AC, 5 A 30 V DC |  |
|  | Max. switching power (resistive load) |  | 2,000 VA, 150 W | 1,250 VA, 150 W |  |
|  | Max. switching voltage |  | 250 V AC, 125 V DC (0.2 A) |  |  |
|  | Max. switching current |  | $8 \mathrm{~A}(\mathrm{AC}), 5 \mathrm{~A}$ (DC) | 5 A (AC, DC) |  |
|  | Nominal operating power |  | 300 mW |  |  |
|  | Min. switching capacity (Reference value)* |  | 10 m A 5 V DC |  |  |
| Electrical characteristics | Insulation resistance (Initial) |  | Min. 1,000M (at 500V DC) Measurement at same location as "Breakdown voltage" section. |  |  |
|  | Breakdown voltage (Initial) | Between open contacts | 1,000 Vrms for 1 min . (Detection current: 10mA.) |  |  |
|  |  | Between contact sets | 2,000 Vrms (1 Form A 1 Form B, 2 Form A) (Detection current: 10mA.) |  |  |
|  |  | Between contact and coil | 3,000 Vrms for 1min. (Detection current: 10mA.) |  |  |
|  | Surge breakdown voltage*2 (Initial) | between contacts and coil | $5,000 \mathrm{~V}$ |  |  |
|  | Operate time [Set time] (at $20^{\circ} \mathrm{C} 68^{\circ} \mathrm{F}$ ) (Initial) |  | Max. 10 ms [ 10 ms ] (Nominal coil voltage applied to the coil, excluding contact bounce time.) |  |  |
|  | Release time [Reset time] (at $20^{\circ} \mathrm{C} 68^{\circ} \mathrm{F}$ ) (Initial) |  | Max. 5 ms [10 ms] (Nominal coil voltage applied to the coil, excluding contact bounce time.) (without diode) |  |  |
| Mechanical characteristics | Shock resistance | Functional | Min. $196 \mathrm{~m} / \mathrm{s}^{2}$ (Half-wave pulse of sine wave: 11 ms ; detection time: $10 \mu \mathrm{~s}$.) |  |  |
|  |  | Destructive | Min. 980 | (Half-wave pulse of sin | 6 ms.$)$ |
|  | Vibration resistance | Functional | 10 to 55 Hz at double amplitude of 2 mm (Detection time: $10 \mu \mathrm{~s}$.) |  |  |
|  |  | Destructive | 10 to 55 Hz at double amplitude of 3.5 mm |  |  |
| Expected life | Mechanical |  | Min. $5 \times 10^{7}$ (at 180 times/min.) |  |  |
|  | Electrical |  | Min. $10^{5}$ (resistive load) |  |  |
| Conditions | Conditions for operation, transport and storage*3 (Not freezing and condensing at low temperature) |  | Ambient temperature: $-40^{\circ} \mathrm{C} \text { to }+60^{\circ} \mathrm{C}$ <br> $-40^{\circ} \mathrm{F}$ to $+140^{\circ} \mathrm{F}$ | Ambient temperature: $-40^{\circ} \mathrm{C}$ to $+65^{\circ} \mathrm{C}$ $-40^{\circ} \mathrm{F}$ to $+149^{\circ} \mathrm{F}$ | Ambient temperature: $-40^{\circ} \mathrm{C} \text { to }+60^{\circ} \mathrm{C}$ <br> $-40^{\circ} \mathrm{F}$ to $+140^{\circ} \mathrm{F}$ |
|  | Max. operating speed |  | 3 cps |  |  |
| Unit weight |  |  | Approx. $4.5 \mathrm{~g} \mathrm{g}$. |  |  |

Notes: *1. This value can change due to the switching frequency, environmental conditions, and desired reliability level, therefore it is recommended to check this with the actual load.
*2. Wave is standard shock voltage of $\pm 1.2 \times 50 \mu \mathrm{~s}$ according to JEC-212-1981
*3. The upper limit of the ambient temperature is the maximum temperature that can satisfy the coil temperature rise value. Refer to Usage, transport and storage conditions in NOTES.

## REFERENCE DATA

1. Max. switching capacity

3.-(1) Coil temperature rise (1 Form A) Tested sample: DSP1a-DC12V, 5 pcs.


## 2.-(1) Life curve (1 Form A 1 Form B)


3.-(2) Coil temperature rise
(1 Form A 1 Form B)
Tested sample: DSP1-DC12V, 5 pcs.

2.-(2) Life curve (1 Form A 1 Form B)

3.-(3) Coil temperature rise ( 2 Form A) Tested sample: DSP2a-DC12V, 5 pcs.

4.-(1) Operate \& release time (without diode, 1 Form A) Tested sample: DSP1a-DC12V, 5 pcs.

4.-(4) Operate \& release time (with diode, 1 Form A)
Tested sample: DSP1a-DC12V, 5 pcs.

5.-(1) Change of pick-up and drop-out voltage (1 Form A)
Tested sample: DSP1a-DC12V, 5 pcs.

6.-(1) Influence of adjacent mounting (1 Form A)
Tested sample: DSP1a-DC12V, 5 pcs.

4.-(2) Operate \& release time (without diode, 1 Form A 1 Form B) Tested sample: DSP1-DC12V, 5 pcs.

4.-(5) Operate \& release time (with diode, 1 Form A 1 Form B) Tested sample: DSP1-DC12V, 5 pcs.

5.-(2) Change of pick-up and drop-out voltage (1 Form A 1 Form B)
Tested sample: DSP1-DC12V, 5 pcs.

6.-(2) Influence of adjacent mounting (1 Form A 1 Form B)
Tested sample: DSP1-DC12V, 5 pcs.

4.-(3) Operate \& release time (without diode, 2 Form A)
Tested sample: DSP2a-DC12V, 5 pcs.)

4.-(6) Operate \& release time (with diode, 2 Form A)
Tested sample: DSP2a-DC12V, 5 pcs.

5.-(3) Change of pick-up and drop-out voltage (2 Form A)
Tested sample: DSP2a-DC12V, 5 pcs.

6.-(3) Influence of adjacent mounting (2 Form A)
Tested sample: DSP2a-DC12V, 5 pcs.


